Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/636,080	MURATA, TAKESHI	
Examiner	Art Unit	
Christopher P. Schwartz	3683	

Christopher P. Schwartz

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED						
Class	Subclass	Date Exami				
188	322.14	4/24/2007	CPS			
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Search Updated		4/24/2007	CPS